Notice of Allowability	Application No.	Applicant(s)	
	10/605,379	BICKFORD ET AL.	
	Examiner	Art Unit	
	Tuyen To	2825	77
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.			
1. \boxtimes This communication is responsive to <u>09/26/2003</u> .			
2. ☑ The allowed claim(s) is/are <u>1-31</u> .			
 Acknowledgment is made of a claim for foreign priority ur a) All b) Some* c) None of the: Certified copies of the priority documents have Certified copies of the priority documents have Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)). * Certified copies not received: 	e been received. been received in Application No cuments have been received in this	national stage applica	
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	IENT of this application.		
 A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give 	itted. Note the attached EXAMINER es reason(s) why the oath or declara	'S AMENDMENT or Nation is deficient.	IOTICE OF
5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.			
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached			
1) hereto or 2) to Paper No./Mail Date			
(b) including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date			
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in the same of	the header according to 37 CFR 1.121(a).	
 DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL. 			
		·	
Attachment(s)	5. Notice of Informal F	Patent Annlication (PT	(O-152)
 Notice of References Cited (PTO-892) Notice of Draftperson's Patent Drawing Review (PTO-948) 	6. ☐ Interview Summary		
_ ,	Paper No./Mail Da	ite	
3. Information Disclosure Statements (PTO-1449 or PTO/SB/Paper No./Mail Date			
4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. Examiner's Statement of Reasons for Allowance 9. Other		
	Yuff) VUTHI PRIMARY I	E SIEK EXAMINER	

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DETAILED ACTION

This is a response to the communication filed on 09/26/2003. Claims 1-31 are pending.

Examiner's amendment

1. In claims:

Claim 5, line 3, after "; ", insert -- and --.

Claim 8, line 3, after "; ", insert -- and --.

Claim 16, line 3, after "; ", insert -- and --.

Claim 25, line 4, after "; ", insert -- and --.

Claim 28, line 4, after "; ", insert -- and --.

2. In Specification:

Page 12, line13, delete "(5)" and insert -- (4) --.

Allowable Subject Matter

- 3. **Claims 1-31** are allowable over the prior art of record.
- 4. The following is an examiner's statement of reasons for allowance:

Claims 1 and similarly recited 21 are allowed because the prior art of record does not teach or fairly suggest a method for predicting manufacturing yield for a proposed integrated circuit, having a combination of steps including the following limitations recited in claim 1 and 21:

(a) providing a multiplicity of different integrated circuit library elements in a design database, each library element linked to a corresponding normalization factor in said design database;

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(c) generating an equivalent circuit count of said proposed design based on said normalization factors and a count of each different library element included in said proposed design; and

(d) calculating a predicted manufacturing yield based on said equivalent circuit count, a predicted density of manufacturing defects and an area of said proposed integrated circuit chip.

Claim 12 is allowed because the prior art of record does not teach or fairly suggest a method for predicting manufacturing yield for an integrated circuit, having a combination of steps including the following limitations recited in claim 12:

- (a) assigning different integrated circuit library elements into circuit types according to a user defined list of attributes;
- (b) compiling a set of yield limiting parameters for each circuit type and determining a normalization factor for each circuit type;
- (d) generating an equivalent circuit count of said proposed design based on said normalization factors for said circuit types and a count of each different library element included in said proposed design; and
- (e) calculating a predicted manufacturing yield based on said equivalent circuit count, a defect density value and an area of said proposed integrated circuit chip.
- 5. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should

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preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

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Conclusion

6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Tuyen To whose telephone number is (571) 272-8319. The examiner can normally be reached on 9:00am-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Matthew Smith can be reached on (571) 272-1907. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pairdirect.uspto.gov. Should you have guestions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (tollfree).

Confintr Tuyen To

Patent examiner

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